

Notice of References Cited	Application/Control No. 10/587,513		Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
	Examiner MICHAEL R. VAUGHAN		Art Unit 2431	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0060955 A1	05-2002	Kumagai, Takashi	369/30.05
*	B	US-2002/0161714 A1	10-2002	BELL et al.	705/57
*	C	US-6,469,239 B1	10-2002	Fukuda, Shinichi	84/602
*	D	US-2004/0111427 A1	06-2004	Gu, Jinsheng	707/101
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.